SCBS199C - FEBRUARY 1991 - REVISED MAY 1997

- State-of-the-Art *EPIC-IIB™* BiCMOS Design **Significantly Reduces Power Dissipation**
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- **High-Impedance State During Power Up** and Power Down
- Latch-Up Performance Exceeds 500 mA Per **JEDEC Standard JESD-17**
- High-Drive Outputs (-32-mA I_{OH}, 64-mA I_{OL})
- **Package Options Include Plastic** Small-Outline (DW) Package, Ceramic Chip Carriers (FK), and Plastic (NT) and Ceramic (JT) DIPs

description

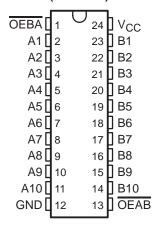
The 'ABT861 are 10-bit transceivers designed for asynchronous communication between data buses. The control-function implementation allows for maximum flexibility in timing.

devices allow noninverted These transmission from the A bus to the B bus or from the B bus to the A bus, depending on the logic levels at the output-enable (OEAB and OEBA) inputs.

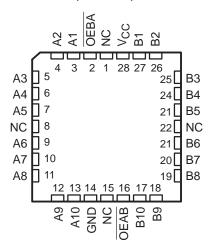
When V_{CC} is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V, OE should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT861 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ABT861 is characterized for operation from -40°C to 85°C.

SN54ABT861 . . . JT PACKAGE SN74ABT861 . . . DW OR NT PACKAGE (TOP VIEW)



SN54ABT861 ... FK PACKAGE (TOP VIEW)



NC - No internal connection



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

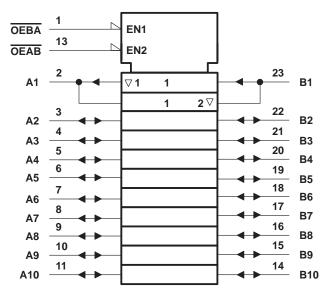
EPIC-IIB is a trademark of Texas Instruments Incorporated.



FUNCTION TABLE

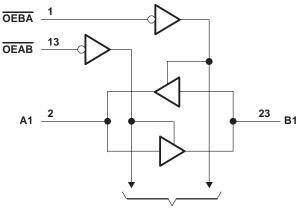
INP	UTS	ODED ATION				
OEAB	OEBA	OPERATION				
L	Н	A data to B bus				
Н	L	B data to A bus				
Н	Н	Isolation				
L	L	Latch A and B (A = B)				

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DW, JT, and NT packages.

logic diagram (positive logic)



To Nine Other Channels

Pin numbers shown are for the DW, JT, and NT packages.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (except I/O ports) (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, VO	–0.5 V to 5.5 V
Current into any output in the low state, IO: SN54ABT861	96 mA
SN74ABT861	128 mA
Input clamp current, $I_{ K }(V_{ I } < 0)$	
Output clamp current, I _{OK} (V _O < 0)	
Package thermal impedance, θ _{JA} (see Note 2): DW package	81°C/W
NT package	67°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions (see Note 3)

					SN74ABT861		UNIT
			MIN	MAX	MIN	MAX	UNIT
VCC	V _{CC} Supply voltage				4.5	5.5	V
VIH	VIH High-level input voltage				2		V
VIL	V _{IL} Low-level input voltage					0.8	V
VI	/ _I Input voltage				0	VCC	V
IOH	OH High-level output current			-24		-32	mA
loL	Low-level output current					64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled	BA	5		5	ns/V
TA	Operating free-air temperature	-	– 55	125	-40	85	°C

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.

SN54ABT861, SN74ABT861 10-BIT TRANSCEIVERS WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A = 25°C			SN54ABT861		SN74ABT861		UNIT		
				MIN	TYP [†]	MAX	MIN	MAX	MIN	MAX	UNII		
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2		-1.2		-1.2	V		
		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.5			2.5		2.5				
\/a		$V_{CC} = 5 V$,	$I_{OH} = -3 \text{ mA}$	3			3		3		v		
VOH		V 45V	I _{OH} = -24 mA	2			2						
		V _{CC} = 4.5 V	$I_{OH} = -32 \text{ mA}$	2*					2				
VOL		V _{CC} = 4.5 V	I _{OL} = 48 mA			0.55		0.55			V		
VOL		VCC = 4.5 V	I _{OL} = 64 mA			0.55*				0.55			
V _{hys}					100						mV		
l ₁	Control inputs	V _{CC} = 5.5 V,	V _I = V _{CC} or GND			±1		±1		±1	μА		
_''	A or B ports	vCC = 5.5 v,	AL = ACC OLGIND			±100		±100		±100	μΑ		
I _{OZPU} ‡		$\frac{V_{CC}}{OE} = 0$ to 2.1 V, $V_{O} = 0.5$ V to 2.7 V,				±50		±50		±50	μА		
lozpd‡		$\frac{\text{V}_{\text{CC}}}{\text{OE}} = 2.1 \text{ V to } 0, \text{ V}_{\text{C}}$	O = 0.5 V to 2.7 V,			±50		±50		±50	μА		
I _{OZH} §		$V_{CC} = 5.5 \text{ V},$	V _O = 2.7 V			50	5	50		50	μΑ		
lozL§		$V_{CC} = 5.5 \text{ V},$	V _O = 0.5 V			-50	90	- 50		- 50	μΑ		
loff		$V_{CC} = 0$,	V_I or $V_O \le 4.5 \text{ V}$			±100	Q'			±100	μΑ		
ICEX		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50		50		50	μА		
IOI		$V_{CC} = 5.5 \text{ V},$	V _O = 2.5 V	-50	-100	-225 [#]	-50	-225 [#]	-50	-225#	mA		
	A or B ports	A or B ports	A or B ports	V _{CC} = 5.5 V,	Outputs high		1	250		250		250	μΑ
Icc				I _O = 0, Outputs low 24 38		38		38	mA				
			$V_I = V_{CC}$ or GND	Outputs disabled		0.5	250		250		250	μΑ	
	Data inputs	One input	V _{CC} = 5.5 V, One input at 3.4 V,	Outputs enabled			1.5		1.5		1.5		
ΔI _{CC}		Other inputs at VCC or GND	Outputs disabled			1.5#		1.5#		1.5#	mA		
	Control inputs	V _{CC} = 5.5 V, One input at 3.4 V, Other inputs at V _{CC} or GND				1.5		1.5		1.5			
Ci	Control inputs	V _I = 2.5 V or 0.5 V			4.5						pF		
C _{io}	A or B ports	V _O = 2.5 V or 0.5 V			10.5						pF		

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply.



[†] All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] This parameter is characterized, but not production tested.

 $[\]S$ The parameters $I_{\mbox{\scriptsize OZH}}$ and $I_{\mbox{\scriptsize OZL}}$ include the input leakage current.

Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[#] This limit may vary among suppliers.

This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

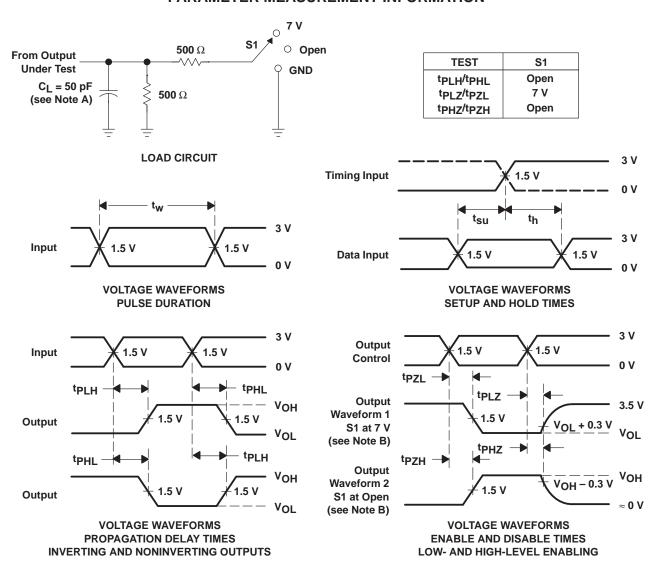
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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			SN54ABT861		SN74ABT861		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	A or B	B or A	1	3.4	4.9	1	5.3	1	5.2	ns ns
tPHL			1	3.2	4.4	1	5	1	4.9†	
^t PZH	OEAB or OEBA	B or A	1	3.5	5	1,	6	1	5.9	ns
tPZL			1	4.6	6	37)	7	1	6.9	
^t PHZ	OEAB or OEBA	B or A	2.1	5.3	6.5	2.1	7.6	2.1	7.5	ns
t _{PLZ}			1.5	5.3	6.6	1.5	7.2	1.5	7.1	

[†] This limit may vary among suppliers.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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